

Supporting Information

Simultaneous optimization of thermoelectric and mechanical properties in p-type NbFeSb via entropy engineering

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1. Supplemental Equations

For an n-element alloy with a disordered ideal solid solution structure, its configurational entropy can be expressed by **Eq. S1**:^{1,2}

$$\Delta S = -R \sum_{i=1}^n x_i \ln x_i \quad (\text{S1})$$

where R and x_i represent the gas constant and the mole fraction of the i -th element, respectively.

Based on the single parabolic band (SPB) model, the Lorentz number (L) can be approximated by **Eq. S2**:³

$$L = 1.5 + \exp\left(\frac{-|S|}{116}\right) \quad (\text{S2})$$

Where S represents the Seebeck coefficient, L ranges between 1.45 and $2.45 \times 10^{-8} \text{ W } \Omega \text{ K}^{-2}$, and it is related to the scattering factor and Fermi level.

To quantitatively assess the point-defect scattering strength, we calculated the disorder scattering parameters using **Eqs. S3, S4, and S5**:⁴⁻⁸

$$\Gamma_m = \frac{1}{3} \left(\frac{M_x}{M_{ave}} \right)^2 \sum f_i \left(1 - \frac{M_i}{M_x} \right)^2 \quad (\text{S3})$$

$$\Gamma_s = \frac{1}{3} \left(\frac{M_x}{M_{ave}} \right)^2 \sum \varepsilon f_i \left(1 - \frac{r_i}{r_x} \right)^2 \quad (\text{S4})$$

$$\Gamma_{\text{total}} = \Gamma_m + \Gamma_s \quad (\text{S5})$$

where M_x , M_{ave} , and M_i denote the average atomic weight on a certain element site, that of all constituent elements, and the atomic weight of a single element, respectively. Similarly, r_i and r_x correspond to the atomic radius of a single element and the average radius on a certain element site, respectively. The subscript i indicates the number of substitutional elements at a certain element site. The parameter ε is a phenomenological

adjustable parameter, typically ranging from 10 to 100.⁶⁻⁸

2. Supplemental Figures

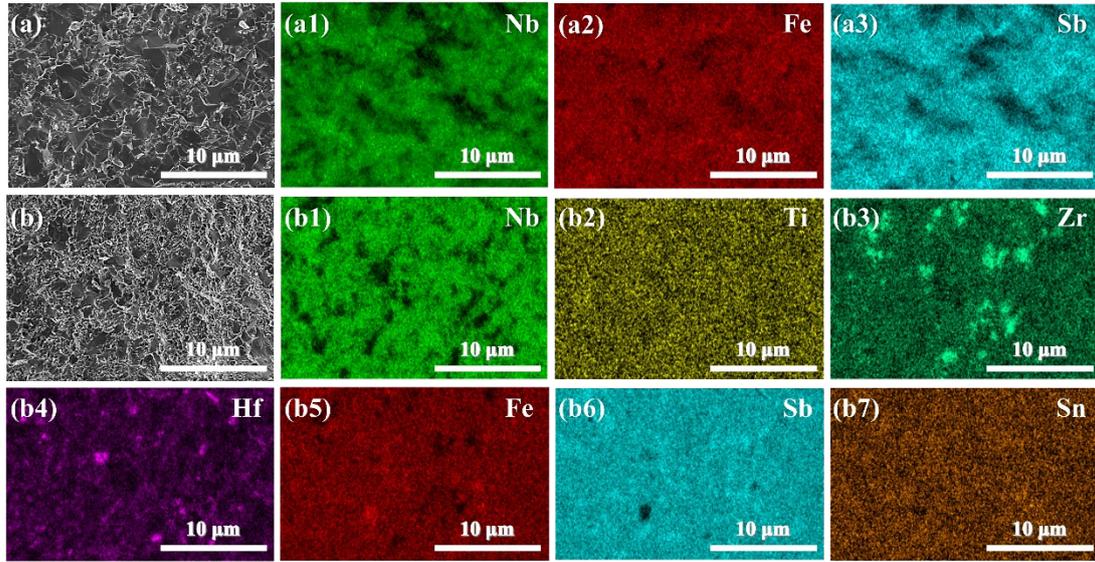


Fig. S1. Elemental mappings of the fracture surfaces for (a) NbFeSb and (b) Nb_{0.82}M_{0.18}FeSb_{0.98}Sn_{0.02}.

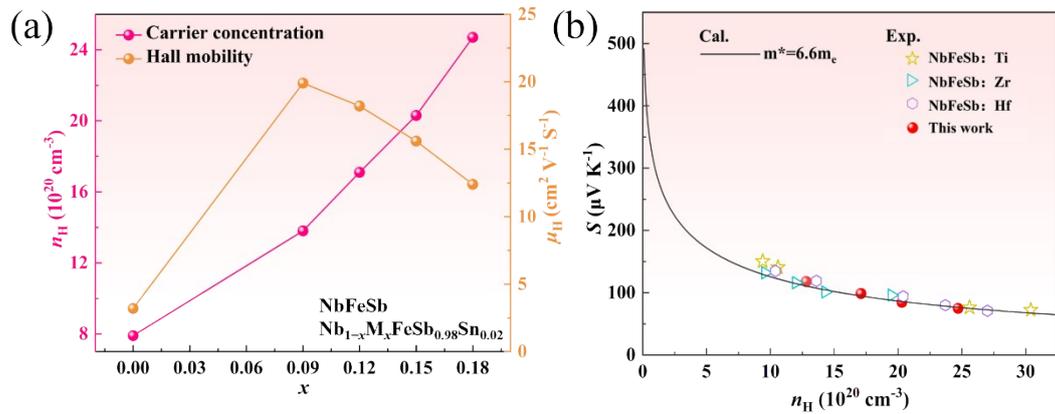


Fig. S2. (a) Room temperature carrier concentration (n_H) and Hall mobility (μ_H). (b) Room temperature Pisarenko plot with $m^* = 6.6 m_e$, where m_e is the electron effective mass.

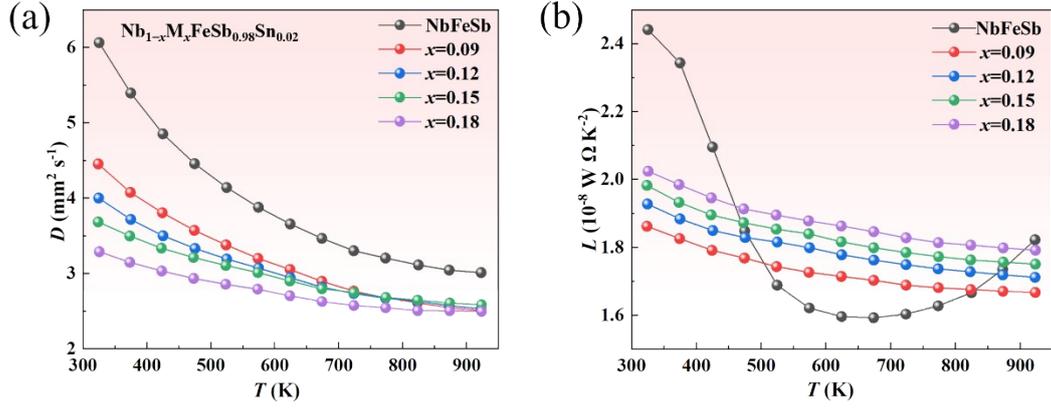


Fig. S3. Temperature dependence of thermal transport parameters for NbFeSb and Nb_{1-x}M_xFeSb_{0.98}Sn_{0.02} ($x = 0.09, 0.12, 0.15,$ and 0.18): (a) Thermal diffusivity (D) and (b) Lorenz number (L).

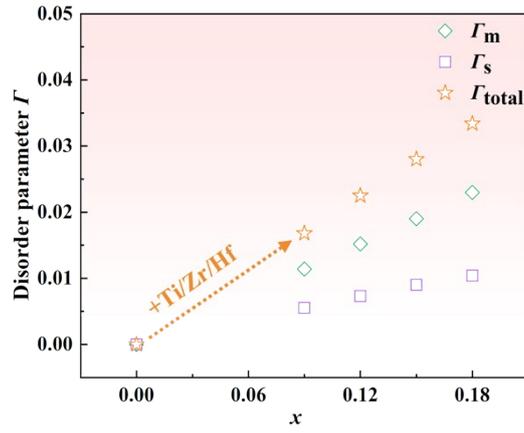


Fig. S4. Calculated disorder parameters of Γ_m , Γ_s , and Γ_{total} of NbFeSb and Nb_{1-x}M_xFeSb_{0.98}Sn_{0.02} ($x=0.09, 0.12, 0.15,$ and 0.18).

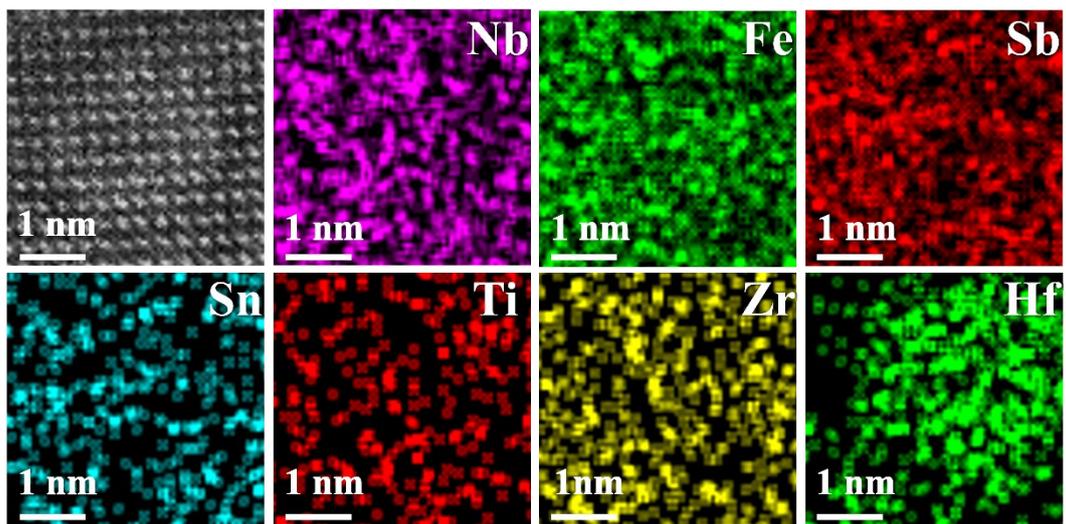


Fig. S5. Elemental mappings of Hf-enriched nanodomains.

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